

Search Notes**Application/Control No.**

10/751,306

Examiner

Mark A. Chapman

Applicant(s)/Patent under Reexamination

MIYAKAWA ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
399	228	12/8/2005	MC
	231		
430	45		
	47		
	111.4		
	107.1		
	126		
<i>update</i>		4/06	<i>mc</i>

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	12/8/2005	MC
reviewed related applications		
<i>update</i>	4/06	<i>mc</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
430	45	4/06	<i>mc</i>
	47		
	111.4		
	107.1		
	126		